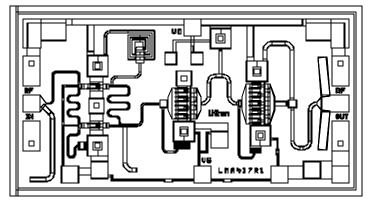


# FEATURES

- ♦ 18 GHz to 24 GHz Frequency Band
- ♦ 19 dB Gain
- ♦ 23 dBm Output Power at Saturation
- ◆ 14 dB Input/Output Return Loss
- ♦ +4 V Dual Bias Supply



### DESCRIPTION AND APPLICATIONS

The Filtronic Solid State LMA417 is a 3-stage medium power PHEMT amplifier that provides 19dB linear power gain with 1-dB gain compression power output of greater than +21dBm for commercial mm-W (millimeter-wave) 18 & 23GHz PCN/PCS and 20GHz SatCom application. Ground is provided to the circuitry through vias to the backside metallization.

# ELECTRICAL SPECIFICATIONS @ T<sub>Ambient</sub> = 25°C

 $(V_{DD} = +4.0V,\, Z_{IN} = Z_{OUT} = 50\Omega)$ 

Parameter	Symbol	<b>Test Conditions</b>	<b>Operating Frequency</b>	Min	Тур	Max	Units
Small Signal Gain	S <sub>21</sub>	60% I <sub>DSS</sub>	18±0.5 GHz	18	19		dB
			20±0.5 GHz	17	18		dB
			23±0.5 GHz	17	18		dB
			24.5-26.5 GHz		18		dB
Saturated Drain Current	$I_{DSS}$			165	360	495	mA
Small Signal Gain Flatness	$\Delta S_{21}$		18-24 GHz		±1		dB
			24-26.5 GHz		±1.5		dB
Power at 1-dB Compression	P-1dB	60% I <sub>DSS</sub>			21		dBm
Power at Saturation	$P_{SAT}$				23		dBm
Input Return Loss	S <sub>11</sub>				-14		dB
Output Return Loss	S <sub>22</sub>				-14		dB
Reverse Isolation	$S_{12}$				-48		dB



# ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	<b>Test Conditions</b>	Min	Max	Units
Drain Voltage	$V_{\rm D}$	$T_{Ambient} = 22 \pm 3  ^{\circ}C$		7	V
Gate Voltage	$V_{G}$	$T_{Ambient} = 22 \pm 3  ^{\circ}C$		-1	V
Operating Current	$I_{OP}$	$T_{Ambient} = 22 \pm 3  ^{\circ}C$		495	mA
RF Input Power	$P_{IN}$	$T_{Ambient} = 22 \pm 3  ^{\circ}C$		15	dBm
Total Power Dissipation	P <sub>TOT</sub>	$T_{Ambient} = 22 \pm 3  ^{\circ}C$		3.5	W
Channel Operating Temperature	$T_{CH}$	$T_{Ambient} = 22 \pm 3  ^{\circ}C$		150	°C
Storage Temperature	$T_{STG}$	_	-65	165	$^{\circ}\! \mathbb{C}$
Maximum Assembly Temperature (1 min. max.)	$T_{MAX}$	_		300	℃

#### Notes:

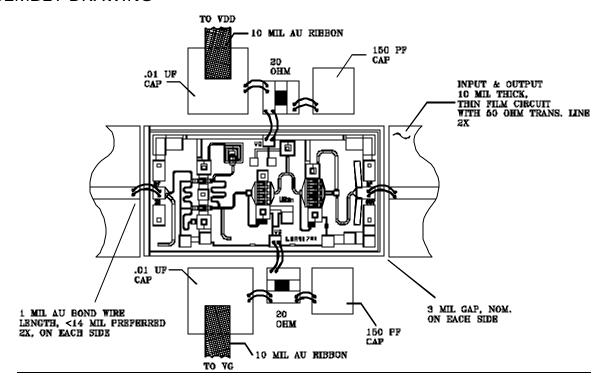
- Operating conditions that exceed the Absolute Maximum Ratings could result in permanent damage to the device.
- Recommended Continuous Operating Limits should be observed for reliable device operation.
- Power Dissipation defined as:  $P_{TOT} \equiv (P_{DC} + P_{IN}) P_{OUT}$ , where

P<sub>DC</sub>: DC Bias Power P<sub>IN</sub>: RF Input Power P<sub>OUT</sub>: RF Output Power

• This GaAs MMIC is susceptible to damage from Electrostatic Discharge. Proper precautions should be used when handling these devices.



### ASSEMBLY DRAWING

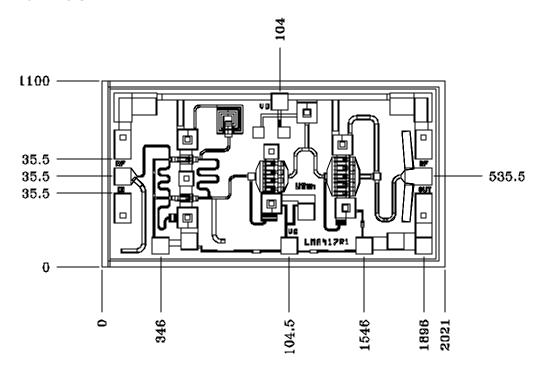


## Notes:

- Recommended lead bond technique is thermocompression wedge bonding with 0.001" (25µm) diameter wire. The bond tool force shall be 35-38 gram. Bonding stage temperature shall be 230-240°C, heated tool (150-160°C) is recommended. Ultrasonic bonding is not recommended.
- The recommended die attach is a eutectic 80/20 Gold/Tin solder, using a stage temperature of 285-290°C.
- Bond on bond or stitch bond acceptable.
- Conductor over conductor acceptable. Conductors must not short.



### MECHANICAL OUTLINE



#### Notes:

- All units are in microns (µm).
- All bond pads are  $100 \times 100 \mu m^2$ .
- Bias pad (V<sub>DD</sub>) size is 100 X 121.5 μm<sup>2</sup>.
- Unless otherwise specified.

## HANDLING PRECAUTIONS

To avoid damage to the devices care should be exercised during handling. Proper Electrostatic Discharge (ESD) precautions should be observed at all stages of storage, handling, assembly, and testing. These devices should be treated as Class 1A (0-500 V). Further information on ESD control measures can be found in MIL-STD-1686 and MIL-HDBK-263.

All information and specifications are subject to change without notice.